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APPLICATION NO.

08/796,519

APPLICANT

Hiroyuki Inoue, et al.

FILING DATE

February 7, 1997

GROUP

2853

U.S. PATENT DOCUMENTS

*EXAMINER
INITIALDOCUMENT
NUMBER

DATE

NAME

CLASS

SUBCLASS

FILING DATE
IF APPROPRIATE

FOREIGN PATENT DOCUMENTS

DOCUMENT
NUMBER

DATE

COUNTRY

CLASS

SUBCLASS

TRANSLATION
YES/NO/
OR ABSTRACT

104

698,497

2/28/96

Europe

—

—

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

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4/28/03

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Sheet 1 of 1

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICELIST OF REFERENCES CITED BY APPLICANT(S)
(Use several sheets if necessary)

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U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
LN		408,241	1/16/91	Europe	—/—	—/—	
LN		585,615	3/9/94	Europe	—/—	—/—	
LN		5-57906	3/9/93	Japan	—/—	—/—	Abstract
LN		5-104735	4/27/93	Japan	—/—	—/—	Abstract

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER

Caron Jager

DATE CONSIDERED

09/01/2003

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